

Search Notes

Application/Control No.

10/729,722

Examiner

Emmanuel Bayard

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	340	2/2/2007	EB
375	229	2/2/2007	EB
375	233	2/2/2007	EB
375	234	2/2/2007	EB
708	322	2/2/2007	EB
708	323	2/2/2007	EB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	2/2/2007	EB